

### FDMA1032CZ

**General Description** 

## 20V Complementary PowerTrench® MOSFET

This device is designed specifically as a single package

solution for a DC/DC 'Switching' MOSFET in cellular

handset and other ultra-portable applications. It

features an independent N-Channel & P-Channel

MOSFET with low on-state resistance for minimum

conduction losses. The gate charge of each MOSFET is also minimized to allow high frequency switching

directly from the controlling device. The MicroFET 2x2

package offers exceptional thermal performance for its

physical size and is well suited to switching applications.

#### **Features**

■ Q1: N-Channel 3.7 A, 20V. R<sub>DS(ON)</sub> = 68 mΩ

7 A, 20V.  $R_{DS(ON)} = 68 \text{ m}\Omega \text{ @ V}_{GS} = 4.5V$  $R_{DS(ON)} = 86 \text{ m}\Omega \text{ @ V}_{GS} = 2.5V$ 

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■ Q2: P-Channel

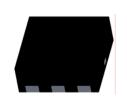
-3.1 A, -20V. R  $_{DS(ON)}$  = 95 m  $\Omega$  @ V  $_{GS}$  = -4.5V R  $_{DS(ON)}$  = 141 m  $\Omega$  @ V  $_{GS}$  = -2.5V

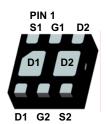
■ Low profile – 0.8 mm maximum – in the new package MicroFET 2x2 mm

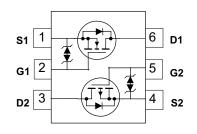
■ HBM ESD protection level > 2 kV (Note 3)

■ RoHS Compliant

 Free from halogenated compounds and antimony oxides







# MicroFET 2x2 Absolute Maximum Ratings

T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V <sub>DS</sub>	Drain-Source Voltage		20	-20	V
V <sub>GS</sub>	Gate-Source Voltage		±12	±12	V
	Drain Current - Continuous	(Note 1a)	3.7	-3.1	Α
I <sub>D</sub>	- Pulsed		6	-6	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	1.4		W
		(Note 1b)	0.7		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		–55 to	°C	

#### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	86 (Single Operation)	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	173 (Single Operation)	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	69 (Dual Operation)	] 'C/VV
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1d)	151 (Dual Operation)	

**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity	
032	FDMA1032CZ	7"	8mm	3000 units	

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Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Units
Off Chai	racteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A} \\ V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$	Q1 Q2	20 –20			V
<u>ΔBV<sub>DSS</sub></u> ΔΤ <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 μA, Referenced to 25°C $I_D$ = -250 μA, Referenced to 25°C	Q1 Q2		15 –12		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$ $V_{DS} = -16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$	Q1 Q2			1 -1	μА
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$	All			±10	μА
On Chai	racteristics (Note 2)						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_{D} = 250 \ \mu A \ V_{DS} = V_{GS}, \qquad I_{D} = -250 \ \mu A$	Q1 Q2	0.6 -0.6	1.0 –1.0	1.5 –1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = 250 μA, Referenced to 25°C $I_D$ = -250 μA, Referenced to 25°C	Q1 Q2		-4 4		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V},  I_D = 3.7 \text{ A}$ $V_{GS} = 2.5 \text{ V},  I_D = 3.3 \text{ A}$ $V_{GS} = 4.5 \text{ V},  I_D = 3.7 \text{ A}, T_J = 125^{\circ}\text{C}$	Q1		37 50 53	68 86 90	mΩ
		$V_{GS} = -4.5V$ , $I_D = -3.1$ A $V_{GS} = -2.5$ V, $I_D = -2.5$ A $V_{GS} = -4.5$ V, $I_D = -3.1$ A, $T_J = 125^{\circ}$ C	Q2		60 88 87	95 141 140	mΩ
<b>g</b> fs	Forward Transconductance	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 3.7 \text{ A} $ $V_{DS} = -10 \text{ V}, \qquad I_{D} = -3.1 \text{ A}$	Q1 Q2		16 –11		S
Dynami	c Characteristics						
C <sub>iss</sub>	Input Capacitance	Q1 V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz	Q1 Q2		340 540		pF
C <sub>oss</sub>	Output Capacitance	Q2	Q1 Q2		80 120		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	Q1 Q2		60 100		pF
Switchir	ng Characteristics (Note	e 2)					
$t_{\text{d(on)}} \\$	Turn-On Delay Time	Q1 V <sub>DD</sub> = 10 V, I <sub>D</sub> = 1 A,	Q1 Q2		8 13	16 24	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ = 4.5 V, $R_{GEN}$ = 6 $\Omega$	Q1 Q2		8 11	16 20	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time	Q2 $V_{DD} = -10 \text{ V}, I_D = -1 \text{ A},$	Q1 Q2		14 37	26 59	ns
t <sub>f</sub>	Turn-Off Fall Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$	Q1 Q2		3 36	6 58	ns
Q <sub>g</sub>	Total Gate Charge	Q1 $V_{DS} = 10 \text{ V}, I_D = 3.7 \text{ A}, V_{GS} = 4.5 \text{ V}$	Q1 Q2		4 7	6 10	nC
Q <sub>gs</sub>	Gate-Source Charge	Q2	Q1 Q2		0.7 1.1		nC
Q <sub>gd</sub>	Gate-Drain Charge	$V_{DS} = -10 \text{ V}, I_{D} = -3.1 \text{ A},$ $V_{GS} = -4.5 \text{ V}$	Q1 Q2		1.1 2.4		nC

#### **Electrical Characteristics**

T<sub>A</sub> = 25°C unless otherwise noted

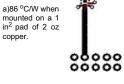
Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Drain-S	Drain-Source Diode Characteristics and Maximum Ratings						
Is	Maximum Continuous Source	-Drain Diode Forward Current	Q1			1.1	Α
			Q2			-1.1	
V <sub>SD</sub>	Source-Drain Diode Forward	$V_{GS} = 0 \text{ V}, I_S = 1.1 \text{ A}$ (Note 2)	Q1		0.7	1.2	V
	Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -1.1 \text{ A}$ (Note 2)	Q2		-0.8	-1.2	
t <sub>rr</sub>	Diode Reverse Recovery	Q1	Q1		11		ns
	Time	$I_F = 3.7 \text{ A}, dI_F/dt = 100 \text{ A/}\mu\text{s}$	Q2		25		
Q <sub>rr</sub>	Diode Reverse Recovery	Q2	Q1		2		nC
	Charge	$I_F = -3.1 \text{ A}, dI_F/dt = 100 \text{ A/}\mu\text{s}$	Q2		9		

- 1.  $R_{\theta,JA}$  is determined with the device mounted on a 1 in<sup>2</sup> oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta,JC}$  is guaranteed by design while  $R_{\theta,JA}$  is determined by the user's board design.

  (a)  $R_{\theta,JA} = 86$  °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For single operation.

  - (b)  $\rm R_{\theta JA}$  = 173 °C/W when mounted on a minimum pad of 2 oz copper. For single operation.
  - (c)  $R_{\theta JA}$  = 69 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For dual operation.
  - (d)  $R_{\theta JA}$  = 151 °C/W when mounted on a minimum pad of 2 oz copper. For dual operation.











- 2. Pulse Test : Pulse Width < 300 us, Duty Cycle < 2.0%
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

### Typical Characteristics Q1 (N-Channel)

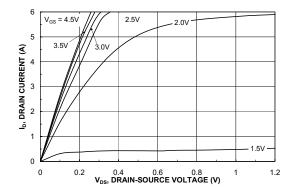


Figure 1. On-Region Characteristics.

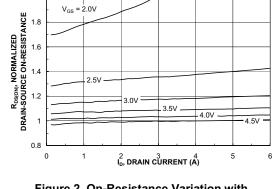


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

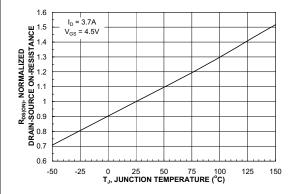


Figure 3. On-Resistance Variation with Temperature.

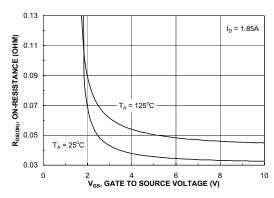


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

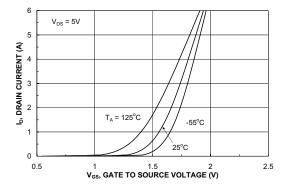


Figure 5. Transfer Characteristics.

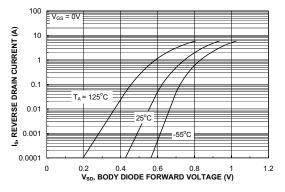
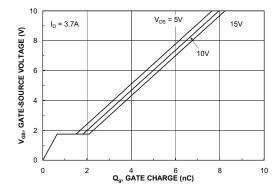


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

f = 1MHz V<sub>GS</sub> = 0 V

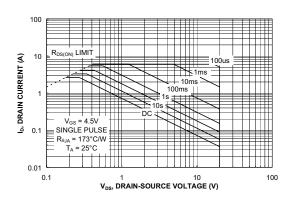
### **Typical Characteristics Q1 (N-Channel)**



500

Figure 7. Gate Charge Characteristics.

Figure 8. Capacitance Characteristics.



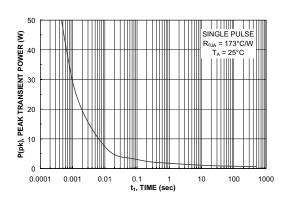


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

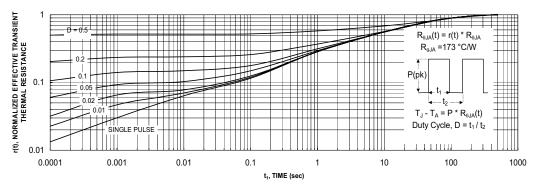


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

### **Typical Characteristics: Q2 (P-Channel)**

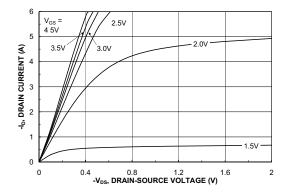


Figure 12. On-Region Characteristics.

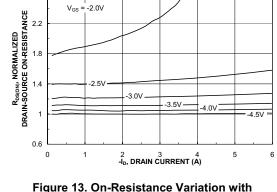


Figure 13. On-Resistance Variation with Drain Current and Gate Voltage.

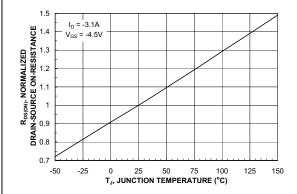


Figure 14. On-Resistance Variation with Temperature.

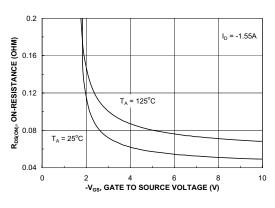


Figure 15. On-Resistance Variation with Gate-to-Source Voltage.

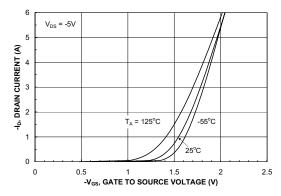


Figure 16. Transfer Characteristics.

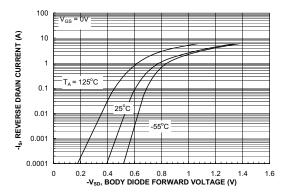
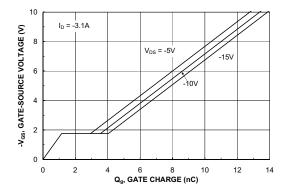


Figure 17. Body Diode Forward Voltage Variation with Source Current and Temperature.

### **Typical Characteristics: Q2 (P-Channel)**



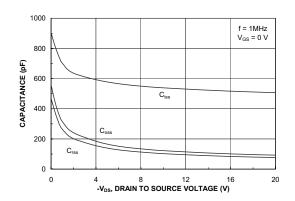
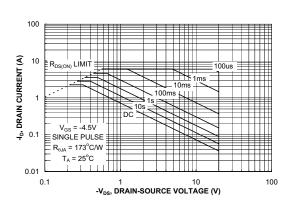


Figure 18. Gate Charge Characteristics.





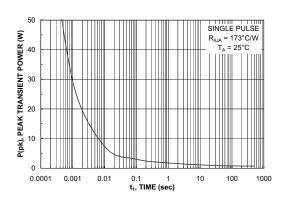


Figure 20. Maximum Safe Operating Area.

Figure 21. Single Pulse Maximum Power Dissipation.

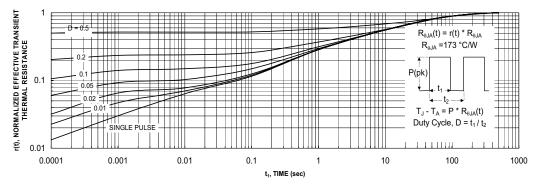
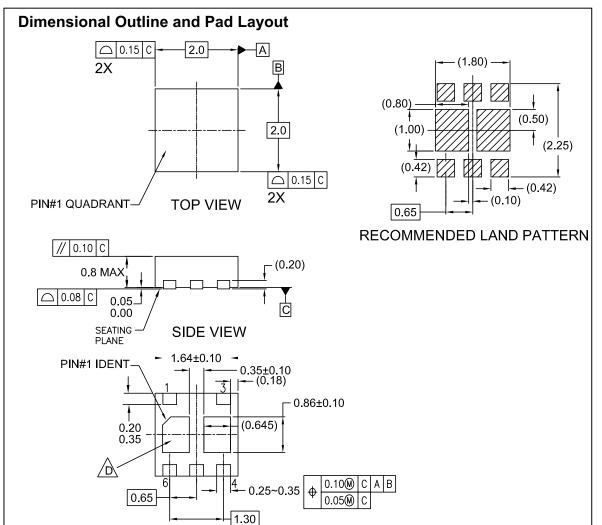


Figure 22. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.



**BOTTOM VIEW** 

### NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-229, VARIATION VCCC EXCEPT AS NOTED.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER

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No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
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